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Kind regards,

Team Nexperia



**Product data sheet** 

## **Product profile**

### 1.1 General description

PNP low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor and NPN Resistor-Equipped Transistor (RET) in a SOT457 (SC-74) small Surface-Mounted Device (SMD) plastic package.

#### 1.2 Features

- Low V<sub>CEsat</sub> (BISS) and resistor-equipped transistor in one package
- Low threshold voltage (<1 V) compared to MOSFET
- Space-saving solution
- Reduction of component count
- AEC-Q101 qualified

## 1.3 Applications

- Supply line switches
- Battery charger switches
- High-side switches for LEDs, drivers and backlights
- Portable equipment

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
TR1; PNP I	ow V <sub>CEsat</sub> transistor					
$V_{CEO}$	collector-emitter voltage	open base	-	-	-60	V
I <sub>C</sub>	collector current		-	-	-1.5	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	-3	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = -1.5 \text{ A};$ $I_B = -100 \text{ mA}$	<u>[1]</u> -	110	175	mΩ
TR2; NPN r	esistor-equipped transistor					
$V_{CEO}$	collector-emitter voltage	open base	-	-	50	V
I <sub>O</sub>	output current		-	-	100	mA
R1	bias resistor 1 (input)		7	10	13	kΩ
R2/R1	bias resistor ratio		0.8	1	1.2	

<sup>[1]</sup> Pulse test:  $t_p \le 300 \ \mu s$ ;  $\delta \le 0.02$ .



# 2. Pinning information

Table 2. Pinning

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Pin	Description	Simplified outline	Graphic symbol
1	base TR1	D. D. D.	
2	input (base) TR2	- 6 - 5 - 4	6 5 4
3	output (collector) TR2	0	R <sub>2</sub>
4	GND (emitter) TR2	1 2 3	
5	collector TR1		TR2
6	emitter TR1		
			1 2 3
			006aab506

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PBLS6023D	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457

## 4. Marking

Table 4. Marking codes

Type number	Marking code
PBLS6023D	KG

3 of 16

60 V, 1.5 A PNP BISS loadswitch

# 5. Limiting values

Table 5. Limiting values

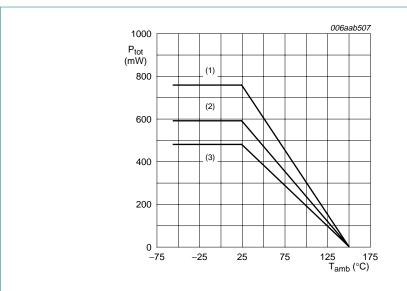
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
TR1; PNP	low V <sub>CEsat</sub> transistor				
$V_{CBO}$	collector-base voltage	open emitter	-	-60	V
$V_{CEO}$	collector-emitter voltage	open base	-	-60	V
$V_{EBO}$	emitter-base voltage	open collector	-	<b>-</b> 5	V
I <sub>C</sub>	collector current		-	-1.5	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	<del>-</del> 3	Α
I <sub>B</sub>	base current		-	-300	mA
I <sub>BM</sub>	peak base current	single pulse; $t_p \le 1 \text{ ms}$	-	<b>–1</b>	Α
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	[1]	370	mW
			[2] _	480	mW
			[3]	630	mW
TR2; NPN	I resistor-equipped transis	tor			
$V_{CBO}$	collector-base voltage	open emitter	-	50	V
$V_{CEO}$	collector-emitter voltage	open base	-	50	V
$V_{EBO}$	emitter-base voltage	open collector	-	10	V
VI	input voltage				
	positive		-	+40	V
	negative		-	-10	V
lo	output current		-	100	mA
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	100	mA
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	[1][2] <b>-</b> [3]	200	mW
Per devic	е				
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	[1] _	480	mW
			[2] _	590	mW
			[3] _	760	mW
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		<b>–</b> 55	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

<sup>[1]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

<sup>[2]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

<sup>[3]</sup> Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



- (1) Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint
- (2) FR4 PCB, mounting pad for collector 1 cm<sup>2</sup>
- (3) FR4 PCB, standard footprint

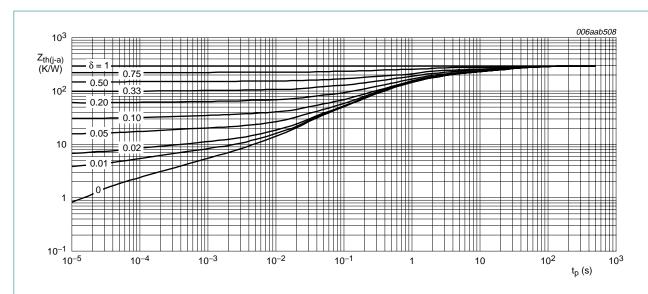
Fig 1. Per device: Power derating curves

## 6. Thermal characteristics

Table 6. Thermal characteristics

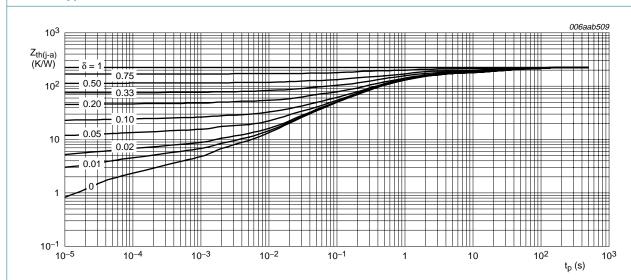
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per device						
$R_{th(j-a)}$	thermal resistance from	in free air	<u>[1]</u> _	-	260	K/W
	junction to ambient		[2] _	-	211	K/W
			[3] _	-	165	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point		-	-	100	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



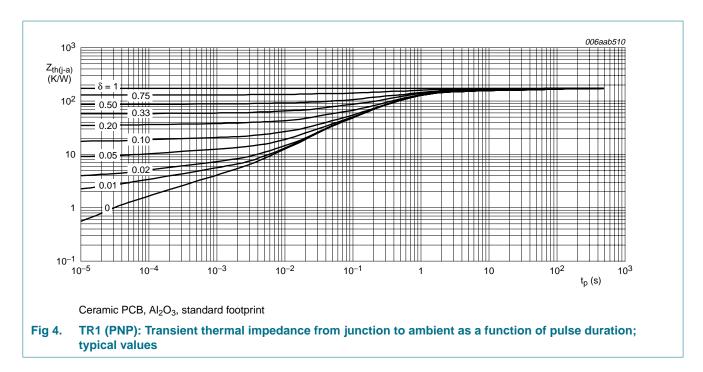
FR4 PCB, standard footprint

Fig 2. TR1 (PNP): Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for collector 1 cm<sup>2</sup>

Fig 3. TR1 (PNP): Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



## 7. Characteristics

Table 7. Characteristics

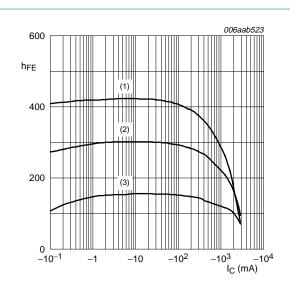
 $T_{amb}$  = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
TR1; PNP	low V <sub>CEsat</sub> transistor					
I <sub>CBO</sub> collector-be current	collector-base cut-off	$V_{CB} = -60 \text{ V}; I_E = 0 \text{ A}$	-	-	-100	nΑ
	current	$V_{CB} = -60 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 ^{\circ}\text{C}$	-	-	<b>–50</b>	μΑ
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = -48 \text{ V}; V_{BE} = 0 \text{ A}$	-	-	-100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-	-	-100	nA
h <sub>FE</sub> DC current g	DC current gain	$V_{CE} = -2 \text{ V}; I_{C} = -100 \text{ mA}$	180	285	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -500 \text{ mA}$	<u>[1]</u> 150	255	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}$	<u>[1]</u> 140	210	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -1.5 \text{ A}$	<u>11</u> 120	185	-	
$V_{CEsat}$	collector-emitter	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	[1] _	-65	-100	mV
	saturation voltage	$I_C = -1 A$ ; $I_B = -50 \text{ mA}$	[1] _	-130	-200	mV
		$I_C = -1 A$ ; $I_B = -100 \text{ mA}$	[1] _	-110	-170	mV
		$I_C = -1.5 \text{ A}; I_B = -100 \text{ mA}$	[1] _	-165	-260	mV
R <sub>CEsat</sub>	collector-emitter	$I_C = -1 A$ ; $I_B = -100 \text{ mA}$	[1] _	110	170	$m\Omega$
	saturation resistance	$I_C = -1.5 \text{ A}; I_B = -100 \text{ mA}$	[1]	110	175	$m\Omega$
$V_{BEsat}$	base-emitter	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	[1]	-0.85	-1	V
	saturation voltage	$I_C = -1.5 \text{ A}; I_B = -100 \text{ mA}$	[1] _	-0.93	-1.1	V

**Table 7.** Characteristics ...continued  $T_{amb} = 25 \,^{\circ}\text{C}$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = -10 \text{ V}; I_{C} = -1 \text{ A}$	[1] -	-0.75	-1.1	V
t <sub>d</sub>	delay time	$V_{CC} = -10 \text{ V}; I_C = -1 \text{ A};$	-	17	-	ns
t <sub>r</sub>	rise time	I <sub>Bon</sub> = -50 mA; -I <sub>Boff</sub> = 50 mA	-	38	-	ns
t <sub>on</sub>	turn-on time	IBOIL — 20 IIIV	-	55	-	ns
ts	storage time		-	350	-	ns
t <sub>f</sub>	fall time		-	65	-	ns
t <sub>off</sub>	turn-off time		-	415	-	ns
f <sub>T</sub>	transition frequency	$I_C = -50 \text{ mA}; V_{CE} = -10 \text{ V};$ f = 100 MHz	-	150	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ $f = 1 \text{ MHz}$	-	30	-	pF
TR2; NPN	resistor-equipped tran	sistor				
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = 50 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
I <sub>CEO</sub>	collector-emitter	$V_{CE} = 30 \text{ V}; I_{B} = 0 \text{ A}$	-	-	1	μΑ
	cut-off current	$V_{CE} = 30 \text{ V}; I_{B} = 0 \text{ A};$ $T_{j} = 150 ^{\circ}\text{C}$	-	-	50	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$	-	-	400	μΑ
h <sub>FE</sub>	DC current gain	$V_{CE} = 5 \text{ V}; I_{C} = 5 \text{ mA}$	30	-	-	
$V_{CEsat}$	collector-emitter saturation voltage	$I_C = 10 \text{ mA}; I_B = 0.5 \text{ mA}$	-	-	150	mV
$V_{I(off)}$	off-state input voltage	$V_{CE} = 5 \text{ V}; I_{C} = 100 \mu\text{A}$	-	1.1	0.8	V
V <sub>I(on)</sub>	on-state input voltage	$V_{CE} = 0.3 \text{ V}; I_{C} = 10 \text{ mA}$	2.5	1.8	-	V
R1	bias resistor 1 (input)		7	10	13	kΩ
R2/R1	bias resistor ratio		0.8	1	1.2	
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	-	2.5	pF

<sup>[1]</sup> Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 



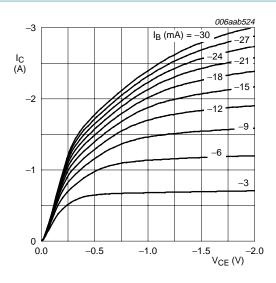
$$V_{CE} = -2 V$$

(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

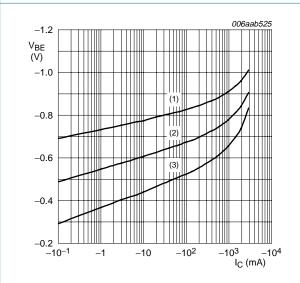
(3)  $T_{amb} = -55 \, ^{\circ}C$ 

Fig 5. TR1 (PNP): DC current gain as a function of collector current; typical values



T<sub>amb</sub> = 25 °C

Fig 6. TR1 (PNP): Collector current as a function of collector-emitter voltage; typical values



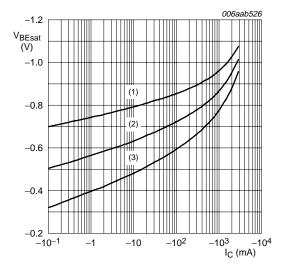


(1) 
$$T_{amb} = -55 \,^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3)  $T_{amb} = 100 \, ^{\circ}C$ 

Fig 7. TR1 (PNP): Base-emitter voltage as a function of collector current; typical values



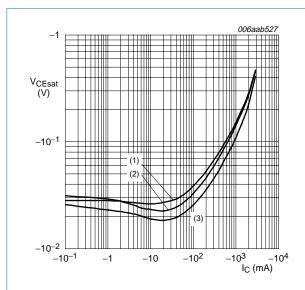
 $I_{\rm C}/I_{\rm B} = 20$ 

(1) 
$$T_{amb} = -55 \,^{\circ}C$$

(2)  $T_{amb} = 25 \,^{\circ}C$ 

(3)  $T_{amb} = 100 \, ^{\circ}C$ 

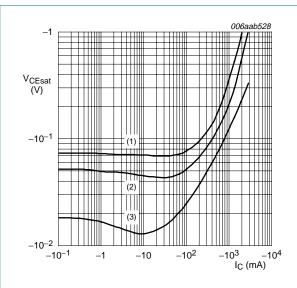
Fig 8. TR1 (PNP): Base-emitter saturation voltage as a function of collector current; typical values



$$I_{\rm C}/I_{\rm B} = 20$$

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

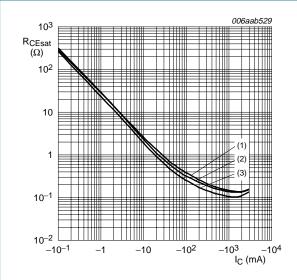
Fig 9. TR1 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$
- (3)  $I_C/I_B = 10$

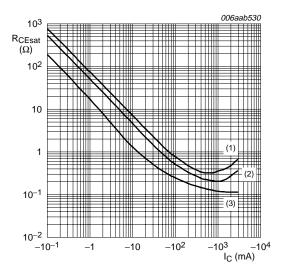
Fig 10. TR1 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values





- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

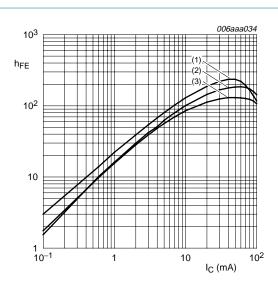
Fig 11. TR1 (PNP): Collector-emitter saturation resistance as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$
- (3)  $I_C/I_B = 10$

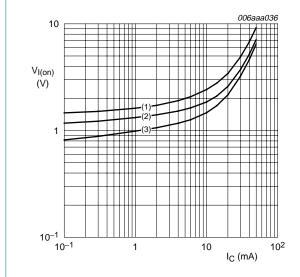
Fig 12. TR1 (PNP): Collector-emitter saturation resistance as a function of collector current; typical values



 $V_{CE} = 5 V$ 

- (1)  $T_{amb} = 150 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -40 \, ^{\circ}C$

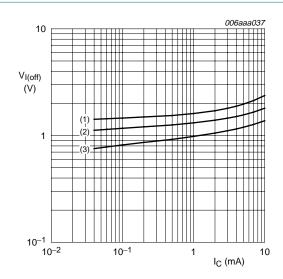
Fig 13. TR2 (NPN): DC current gain as a function of collector current; typical values



 $V_{CE} = 0.3 \text{ V}$ 

- (1)  $T_{amb} = -40 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

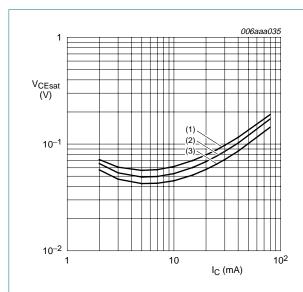
Fig 14. TR2 (NPN): On-state input voltage as a function of collector current; typical values



 $V_{CE} = 5 V$ 

- (1)  $T_{amb} = -40 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

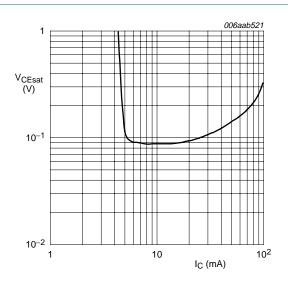
Fig 15. TR2 (NPN): Off-state input voltage as a function of collector current; typical values



 $I_{\rm C}/I_{\rm B} = 20$ 

- (1) T<sub>amb</sub> = 100 °C
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -40 \, ^{\circ}C$

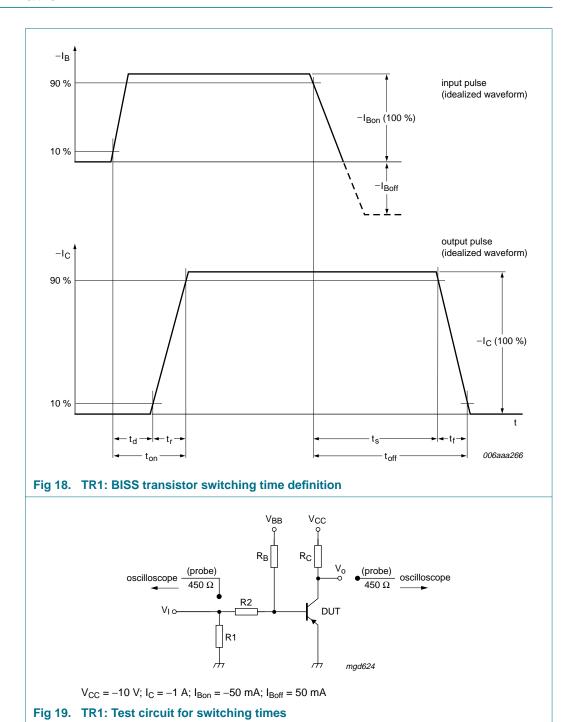
Fig 16. TR2 (NPN): Collector-emitter saturation voltage as a function of collector current; typical values



 $I_C/I_B = 50$ ;  $T_{amb} = 25$  °C

Fig 17. TR2 (NPN): Collector-emitter saturation voltage as a function of collector current; typical values

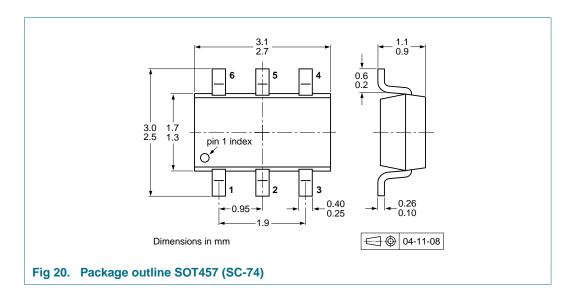
## 8. Test information



## 8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

## 9. Package outline



# 10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description		Packing q	uantity
				3000	10000
PBLS6023D	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	<u>[3]</u>	-125	-165

[1] For further information and the availability of packing methods, see  $\underline{\text{Section 13}}$ .

[2] T1: normal taping

[3] T2: reverse taping



# 11. Revision history

### Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBLS6023D_1	20090813	Product data sheet	-	-

## 12. Legal information

#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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#### 13. Contact information

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